

Integrated Device Technology, Inc. 6024 Silver Creek Valley Road, San Jose, CA - 95138

PRODUCT	/PROCESS C	HANGE	NOTIC	E (PCN)	
PCN #: A0709-01	OATE: 16-Nov-2007	MEANS OF	DISTINGUIS	SHING CHANGE	ED DEVICES:
Product Affected: 14mm x 14mm TQF (Standard and Green Refer to Attachment II for the a Date Effective: 16-Feb-2008	1)	☐ Product I ☐ Back Ma ☐ Date Coo ☐ Other	rk Lot#	will have a "L" p	prefix
Contact: Geoffrey Cortes					
Title: Product Quality Assurance		Attachment:		Yes	☐ No
Phone #: (408) 284-8321					
Fax #: (408) 284-1450		Samples: F	lease contact	your local sales re	epresentative for
E-mail: Geoffrey.Cortes@idt.com		_		& availability.	
DESCRIPTION AND PURPOSE OF CI	HANGE:				
☐ Die Technology					
 □ Wafer Fabrication Process □ Assembly Process □ Equipment □ Material 	Wafer Fabrication Process Assembly Process This notification is to advise our customers that IDT is changing the assembly of 14mm x 14mm TQFP-100 both standard and green version from AMKOR, Korea to Equipment ASAT, China. There is no change to the moisture performance of these packages. Material				
	the state of the s			nent II shows the	
☐ Data Sheet	riceted list of part humbe	.13.			
Other					
RELIABILITY/QUALIFICATION SUI	MMARY:				
Refer to qualification data shown in attach	nment I.				
CUSTOMER ACKNOWLEDGMENT	OF RECEIPT•				
IDT records indicate that you require writ to grant approval or request additional inf it will be assumed that this change is acce IDT reserves the right to ship either version on the earlier version has been depleted.	tten notification of this cl formation. If IDT does no optable.	ot receive ack	nowledgemen	t within 30 days	of this notice
Customer:		Approv	al for shipn	ients prior to	effective date.
Name/Date:	E-N	Mail Address:			
Title:	Pho	one#/Fax#:			
CUSTOMER COMMENTS:					
IDT ACKNOWLEDGMENT OF RECI	EIPT:				
RECD. BY:		DATE:			_

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Refer To QCA-1795



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PRODUCT/PROCESS CHANGE NOTICE (PCN)

ATTACHMENT I - PCN # : A0709-01

PCN Type: Manufacturing Site - Change of Assembly Location

Data Sheet Change: None

No change in moisture sensitivity level (MSL)

Detail Of Change:

This notification is to advise our customers that IDT is changing the assembly of 14mm x 14mm TQFP 100 both standard and green version from AMKOR, Korea to ASAT, China. There is no change to the moisture performance of these packages using the assembly material set as listed in the tables under each group.

There is no change in the moisture sensitivity level (MSL).

Attachment II shows the affected part numbers.

Sample Availability:

Samples for each package type are available for customer evaluation, but may not be available for all devices.

Please contact your local IDT sales representative for your sample request and availability.



PRODUCT/PROCESS CHANGE NOTICE (PCN)

ATTACHMENT I - PCN #: A0709-01

Qualification Information and Qualification Data:

Affected Packages: TQFP

14mm 14mm 100L (DQ/DQG packages)

Assembly Material: See Table below

Description	Existing	Add	
Assembly Location	AMKOR, Korea	ASAT, China	
	Die Attach: Ablestik 3230	2200	
	Wire: 1.0 mil Au	1.0 mil Au	
Assembly Materials	Mold Compound: EME-G700L	G700	
	Lead Frame: Copper Alloy	Copper Alloy	
	Plating: Sn/Pb (standard) and matte	Sn/Pb (standard) and matte 100% Sn	
	100% Sn (green)	(green)	

Qualification Plan #: P07-09-04

Test Vehicle: 14mm x 14mm TQFP-52

Qualification Test Plan and Results:

Test Description	Test Method	Test Results (SS/Rej)
* Temperature Cycling (Cond B, 1000 cycles)	JESD22-A104	77/0
* Auto Clave (121°C, 100% RH, 96 hours)	JESD22-A102	77/0
High Temperature Stabilization Bake (150 °C, 1000 hours)	JESD22-A103	77/0

Notes: * Test requires moisture pre-conditioning sequence per JESD22-A113.



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Tin Whisker Evaluation Test Data (JESD22A121 / JESD201)

Test Vehicle: 7mm x 7mm TQFP-48 and 14mm x 20mm LQFP-100

Test Description	Test Condition	Test Duration	Spec Limits	Test Results (SS/Rej)
High Temperature / Humidity Storage	60°C / 87% RH	0, 1000, 2000, 3000 hours	< 40μm	6/0, 6/0, 6/0
Ambient Temperature / Humidity Storage	30°C / 60% RH	0, 1000, 2000, 3000 hours	< 40μm	6/0, 6/0, 6/0
Temperature Cycling	-55°C to +85°C	0, 500, 1000 cycles	< 40μm	6/0, 6/0, 6/0

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PRODUCT/PROCESS CHANGE NOTICE (PCN)

ATTACHMENT II - PCN #: A0709-01

Affected Part Number

Part Number	Part Number	Part Number
IDT82V3280DQ	IDT82V3285DQ	IDT82V3380DQGI
IDT82V3280DQG	IDT82V3285DQG	IDT82V3380DQI

Notes: For T & R (shipping method) "8" suffix is added to the IDT part# respectively.